

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LIN ET AL.	
		Examiner Polin Chieu	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,385,389	05-2002	Maruyama et al.	386/95
	B	US-6,381,398	04-2002	Yamauchi et al.	386/52
	C	US-6,173,113	01-2001	Okada et al.	386/95
	D	US-6,160,952	12-2000	Mimura et al.	386/95
	E	US-5,745,643	04-1998	Mishina, Masamitsu	386/106
	F	US-5,621,840	04-1997	Kawamura et al.	386/68
	G	US-5,276,665	01-1994	Aoki et al.	369/53.2
	H	US-6,434,326	08-2002	Kondo et al.	386/125
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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